N-channel TrenchPLUS logic level FET

Rev. 04 — 16 February 2009

Product data sheet

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS diodes for clamping, ElectroStatic Discharge (ESD) protection and temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

1.4 Quick reference data

 Allows responsive temperature monitoring due to integrated temperature sensor

1.3 Applications

- 12 V and 24 V high power motor drives
- Automotive and general purpose power switching

- Low conduction losses due to low on-state resistance
- Q101 compliant
- Electrical Power Assisted Steering (EPAS)
- Protected drive for lamps

| Table 1. | Quick reference | | | | | | |
|---------------------|--|---|-----|------|-------|-------|------|
| Symbol | Parameter | Conditions | | Min | Тур | Max | Unit |
| I _D | drain current | V _{GS} = 5 V; T _{mb} = 25 °C; see <u>Figure 2</u> ; see <u>Figure 3</u> | [1] | - | - | 140 | А |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 1</u> | | - | - | 272 | W |
| Tj | junction temperature | | | -55 | - | 175 | °C |
| R _{DSon} | drain-source on-state resistance | V_{GS} = 10 V; I _D = 50 A; T _j = 25 °C | | - | 5.2 | 6.2 | mΩ |
| | | V_{GS} = 4.5 V; I_D = 50 A; T_j = 25 °C | | - | 6 | 7.7 | mΩ |
| | | $V_{GS} = 5 \text{ V}; I_D = 50 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 7</u> ; see <u>Figure 8</u> | | - | 5.8 | 7 | mΩ |
| $S_{F(TSD)}$ | temperature sense diode temperature coefficient | I _F = 250 μA; T _j > -55 °C; T _j < 175 °C | | -1.4 | -1.54 | -1.68 | mV/K |
| V _{F(TSD)} | temperature sense diode forward voltage | $I_F = 250 \ \mu A; T_j = 25 \ ^{\circ}C$ | | 648 | 658 | 668 | mV |
| | | | | | | | |

[1] Current is limited by power dissipation chip rating.



2. Pinning information

| Table 2. | Pinning | information | | |
|----------|---------|-----------------------------|--------------------|----------------|
| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| 1 | G | gate | | d a |
| 2 | А | anode | mb | |
| 3 | D | drain | | |
| 4 | К | cathode | | g (→ ↓ ← ↓) |
| 5 | S | source | | |
| mb | D | mounting base; connected to | | |
| | | drain | SOT426 (D2PAK) | MBL306 S K |

3. Ordering information

Table 3. Ordering information Type number Package Name Description Version BUK9107-40ATC D2PAK plastic single-ended surface-mounted package (D2PAK); 5 leads (one lead cropped) SOT426

4. Limiting values

Table 4. Limiting values

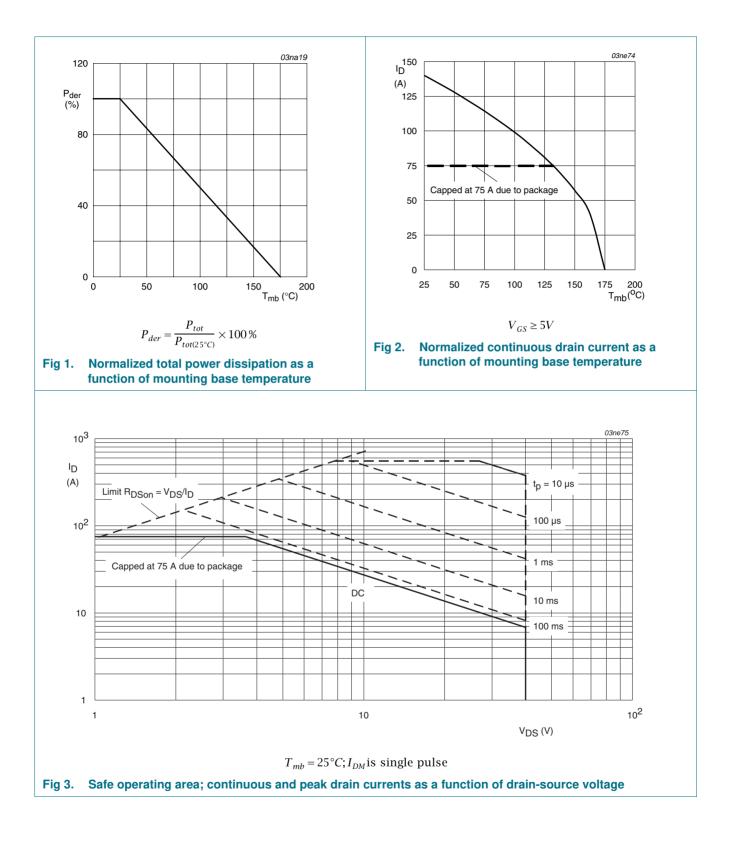
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | | Min | Max | Unit |
|----------------------------|--|---|-----|------|-----|------|
| V _{DS} | drain-source voltage | T _j ≥ 25 °C; T _j ≤ 175 °C; | [1] | - | 40 | V |
| V _{GS} | gate-source voltage | | [1] | -15 | 15 | V |
| ID | drain current | $T_{mb} = 25 \text{ °C}; V_{GS} = 5 \text{ V}; \text{ see } Figure 2; \text{ see } Figure 3$ | [2] | - | 140 | А |
| | | $T_{mb} = 25 \text{ °C}; V_{GS} = 5 \text{ V}; \text{ see } \underline{Figure 2}; \text{ see } \underline{Figure 3}$ | [3] | - | 75 | А |
| | | T_{mb} = 100 °C; V_{GS} = 5 V; see <u>Figure 2</u> | [3] | - | 75 | А |
| I _{DM} | peak drain current | $T_{mb} = 25 \text{ °C}; t_p \le 10 \mu\text{s}; \text{ pulsed}; \text{ see } \frac{\text{Figure } 3}{10 \mu\text{s}}$ | | - | 560 | А |
| P _{tot} | total power dissipation | T _{mb} = 25 °C; see <u>Figure 1</u> | | - | 272 | W |
| I _{DG(CL)} | drain-gate clamping current | pulsed; $t_p = 5 \text{ ms}; \delta = 0.01$ | | - | 50 | mA |
| I _{GS(CL)} | gate-source clamping | pulsed; $t_p = 5 \text{ ms}; \delta = 0.01$ | | - | 50 | mA |
| | current | continuous | | - | 10 | mA |
| V _{isol(FET-TSD)} | FET to temperature sense diode isolation voltage | | | -100 | 100 | V |
| T _{stg} | storage temperature | | | -55 | 175 | °C |
| Tj | junction temperature | | | -55 | 175 | °C |
| V _{DGS} | drain-gate voltage | I _{DG} = 250 μA; | [1] | - | 40 | V |
| Source-drain | n diode | | | | | |
| I _S | source current | T _{mb} = 25 °C; | [2] | - | 140 | А |
| | | T _{mb} = 25 °C; | [3] | - | 75 | А |
| I _{SM} | peak source current | $t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$ | | - | 560 | А |
| Clamping | | | | | | |
| E _{DS(CL)S} | non-repetitive drain-source clamping energy | $\label{eq:ID} \begin{array}{l} I_D = 75 \text{ A}; \ V_{DS} \leq 40 \text{ V}; \ V_{GS} = 5 \text{ V}; \ R_{GS} = 10 \text{ k}\Omega; \\ \text{unclamped}; \ T_{j(\text{init})} = 25 \ ^\circ\text{C} \end{array}$ | | - | 1.4 | J |
| Electrostatic | discharge | | | | | |
| V _{esd} | electrostatic discharge voltage | HBM; C = 100 pF; R = 1.5 k\Omega; pins 1, 3, 5 | | - | 6 | kV |

[1] Voltage is limited by clamping.

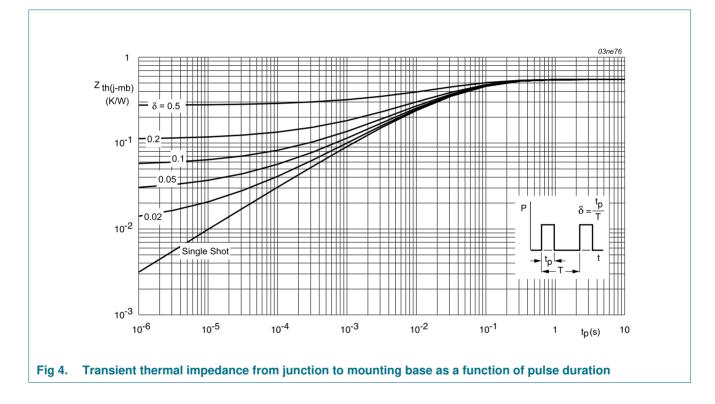
[2] Current is limited by power dissipation chip rating.

[3] Continuous current is limited by package.



5. Thermal characteristics

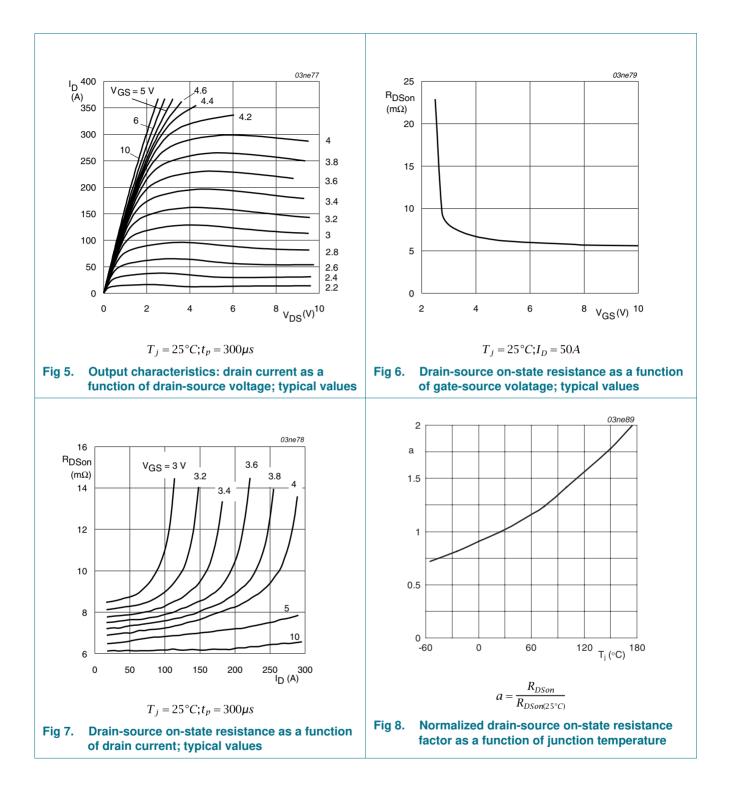
| Table 5. | Thermal characteristics | | | | | |
|-----------------------|---|--|-----|-----|------|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| R _{th(j-a)} | thermal resistance from junction to ambient | mounted on printed-circuit board; minimum footprint | - | - | 50 | K/W |
| R _{th(j-mb)} | thermal resistance from junction to mounting base | see Figure 4 | - | - | 0.55 | K/W |

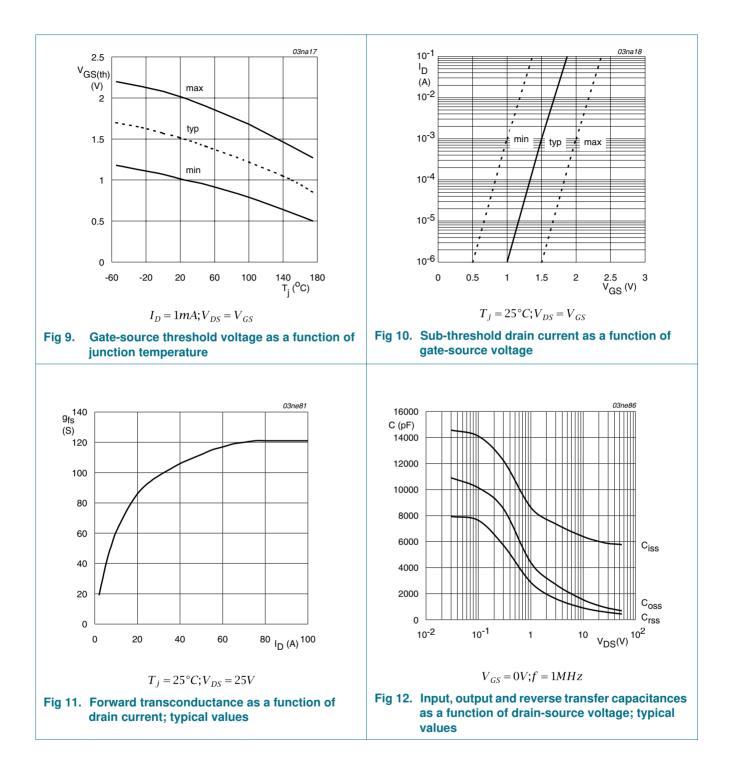


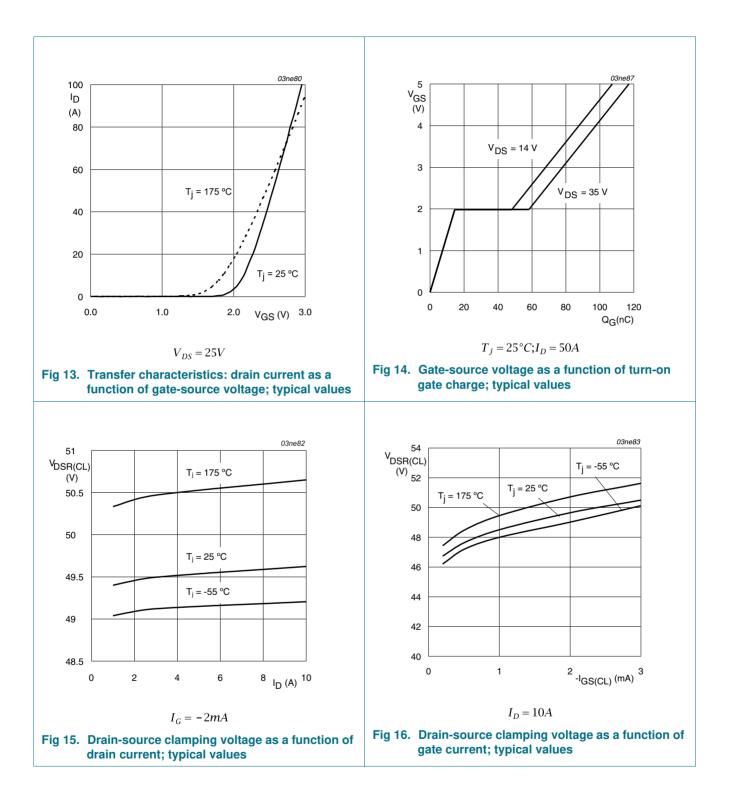
6. Characteristics

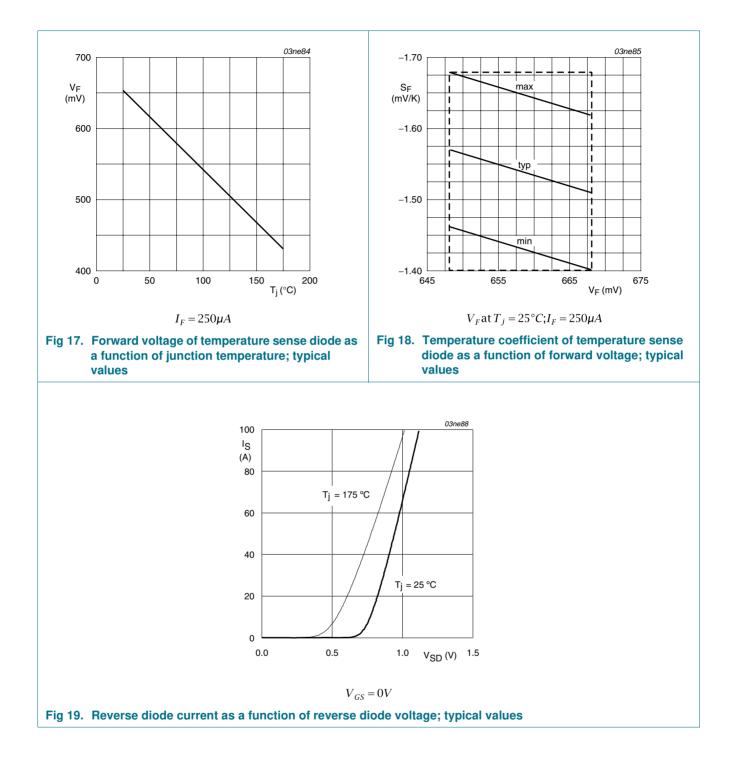
| Table 6. | Characteristics | | | | | |
|----------------------|--|--|------|-------|-------|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| Static cha | racteristics | | | | | |
| $V_{(BR)DG}$ | drain-gate (Zener | $I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | 40 | - | - | V |
| | diode) breakdown voltage | $I_D = 0.25 \text{ mA}; \text{V}_{GS} = 0 \text{V}; \text{T}_j = \text{-}55 ^\circ\text{C}$ | 40 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 25 °C; see <u>Figure 9</u> | 1 | 1.5 | 2 | V |
| | | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see Figure 9 | 0.5 | - | - | V |
| | | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see Figure 9 | - | - | 2.3 | V |
| I _{DSS} | drain leakage current | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$ | - | 0.1 | 100 | μA |
| | | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$ | - | - | 250 | μA |
| V _{(BR)GSS} | gate-source breakdown voltage | $ I_G = 1 \text{ mA}; V_{DS} = 0 \text{ V}; T_j > -55 \text{ °C}; \\ T_j < 175 \text{ °C} $ | 12 | 15 | - | V |
| | | I _G = -1 mA; V _{DS} = 0 V; T _j > -55 °C; T _j < 175 °C | 12 | 15 | - | V |
| I _{GSS} | gate leakage current | $V_{DS} = 0 V; V_{GS} = 5 V; T_j = 25 \text{ °C}$ | - | 5 | 1000 | nA |
| | | $V_{DS} = 0 \text{ V}; V_{GS} = -5 \text{ V}; T_j = 25 \text{ °C}$ | - | 5 | 1000 | nA |
| R _{DSon} | drain-source on-state resistance | V _{GS} = 5 V; I _D = 50 A; T _j = 25 °C; see <u>Figure 7</u> ; see <u>Figure 8</u> | - | 5.8 | 7 | mΩ |
| | | $V_{GS} = 5 \text{ V}; I_D = 50 \text{ A}; T_j = 175 \text{ °C};$ see <u>Figure 7</u> ; see <u>Figure 8</u> | - | - | 14 | mΩ |
| | | V_{GS} = 4.5 V; I _D = 50 A; T _j = 25 °C | - | 6 | 7.7 | mΩ |
| | | V_{GS} = 10 V; I _D = 50 A; T _j = 25 °C | - | 5.2 | 6.2 | mΩ |
| V _{F(TSD)} | temperature sense diode forward voltage | $I_F = 250 \ \mu A; \ T_j = 25 \ ^{\circ}C$ | 648 | 658 | 668 | mV |
| $S_{F(TSD)}$ | temperature sense diode temperature coefficient | I _F = 250 μA; T _j > -55 °C; T _j < 175 °C | -1.4 | -1.54 | -1.68 | mV/K |
| $V_{F(TSD)hys}$ | temperature sense diode forward voltage hysteresis | I_F > 125 μA; I_F < 250 μA; T_j = 25 °C | 25 | 32 | 50 | mV |
| Dynamic o | characteristics | | | | | |
| C _{iss} | input capacitance | $V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$ | - | 5836 | - | pF |
| C _{oss} | output capacitance | T _j = 25 °C; see <u>Figure 12</u> | - | 958 | - | pF |
| C _{rss} | reverse transfer capacitance | | - | 595 | - | pF |
| t _{d(on)} | turn-on delay time | $V_{DS} = 30 \ V; \ R_L = 1.2 \ \Omega; \ V_{GS} = 5 \ V;$ | - | 3 | - | μs |
| t _r | rise time | $R_{G(ext)} = 1 \text{ k}\Omega; T_j = 25 \text{ °C}$ | - | 10 | - | μs |
| t _{d(off)} | turn-off delay time | | - | 17 | - | μs |
| t _f | fall time | | - | 11 | - | μs |

| Table 6. | Characteristics continued | | | | | | | |
|-----------------|-------------------------------|---|-----|------|-----|------|--|--|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit | | |
| L _D | internal drain inductance | measured from upper edge of drain mounting base to centre of die; T _j = 25 °C | - | 2.5 | - | nH | | |
| L _S | internal source inductance | measured from source lead to source bond pad; $T_j = 25 \text{ °C}$ | - | 7.5 | - | nH | | |
| Source-d | rain diode | | | | | | | |
| V_{SD} | source-drain voltage | $I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 19</u> | - | 0.85 | 1.2 | V | | |
| t _{rr} | reverse recovery time | I_{S} = 20 A; dI _S /dt = -100 A/µs; V _{GS} = -10 V; | - | 85 | - | ns | | |
| Q _r | recovered charge | V _{DS} = 30 V; T _j = 25 °C | - | 250 | - | nC | | |









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7. Package outline

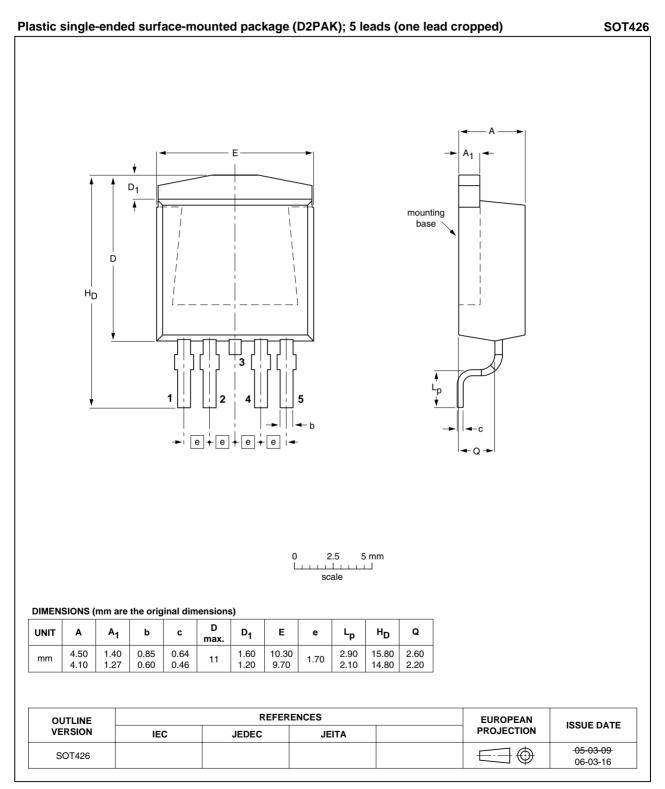


Fig 20. Package outline SOT426 (D2PAK)

8. Revision history

Table 7. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|--------------------------------------|---------------------------------|---|-----------------------|-------------------------|
| BUK9107-40ATC_4 | 20090216 | Product data sheet | - | BUK9107_40ATC-03 |
| Modifications: | | t of this data sheet has be of NXP Semiconductors. | e . | y with the new identity |
| | Legal texts | have been adapted to th | ie new company name v | vhere appropriate. |
| BUK9107_40ATC-03 (9397 750 08724) | 20020122 | Product data sheet | - | BUK9107_40ATC-02 |
| BUK9107_40ATC-02 (9397 750 08709) | 20010829 | Product data sheet | - | BUK9107_40ATC-01 |
| BUK9107_40ATC-01 (9397 750 08319) | 20010814 | Product data sheet | - | - |
| | | | | |

9. Legal information

9.1 Data sheet status

| Document status [1][2] | Product status ^[3] | Definition |
|--------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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